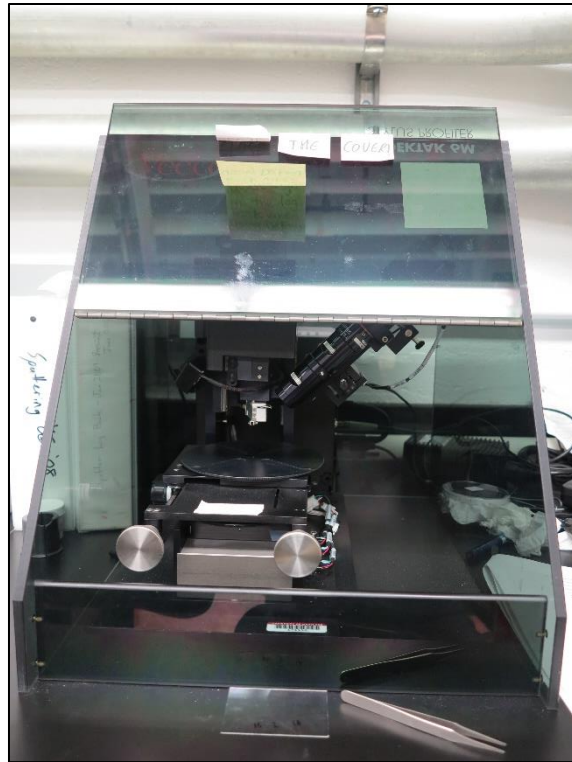


Physical Properties – Thickness of Thin Films



Dektak 3 Surface Profilometer

Stylus Profilers

- Specification
 - Vertical Range: 10 nm to 131,000 nm
 - Vertical Resolution: 0.1 nm maximum
 - Scan Length Range: 50 microns to 50 mm
- Measurement Options
 - Programmable over 200 locations
 - 3D mapping